## Search Notes



Application/C	ontrol N	0
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Applicant(s)/Patent Under Reexamination

CHUNG ET AL.

**Examiner** 

Art Unit

Wendmagegn, Girumsew

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## **SEARCHED**

Class	Subclass	Date	Examiner
386	95	7/14/2009	gw
386	124	1/4/2009	gw
386	125	7/14/2009	gw

## **SEARCH NOTES**

Search Notes	Date	Examiner
US-PGPUB;USPAT;USOCR;EPO;JPO;DERWENT;IBM_TDB	7/14/2009	gw
Consulted Thai Tran	7/13/2009	gw
Inventor(s) search	7/14/2009	gw

## Subclass Date Examiner

386 95 7/14/2009 gw   386 124 7/14/2009 gw	
296 124 7/14/2000 200	
386   124     //14/2009   gw	
386 125 7/14/2009 gw	

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